

Notice of References Cited	Application/Control No. 10/510,089		Applicant(s)/Patent Under Reexamination EBIHARA ET AL.	
	Examiner DIANE MIZRAHI		Art Unit 2165	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0126139	07-2003	Lee et al.	707/100
*	B	US-7,043,088	05-2006	Chiu et al.	382/233
*	C	US-6,847,950	01-2005	Kamibayashi et al.	705/57
*	D	US-2006/0059102	03-2006	Ebihara et al.	705/059
*	E	US-2006/0230131	10-2006	Ebihara et al.	709/223
*	F	US-2004/0133448	07-2004	Higashi et al.	705/001
*	G	US-2003/0229593	12-2003	Raley et al.	705/55
*	H	US-2002/0013772	01-2002	Peinado, Marcus	705/51
*	I	US-2005/0152596 A1	07-2005	Walmsley, Simon Robert	382/162
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.